Search Notes			

•	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/895,347	CRINON ET AL.
	Examiner	Art Unit
	Hai Tran	2623

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			•

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Tommy Chin (101 Panel)	6/1/2006	HVT